Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/645,967	YANG ET AL.	
Examiner	Art Unit	
Bruck Kifle, Ph.D.	1624	

SEARCHED			
Class	Subclass	Date	Examiner
514	291 411	4/1/2005	вк
540	456	4/1/2005	вк
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
514	291 411	4/1/2005	вк	
540	456	4/1/2005	ВК	
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SEARCH NOT (INCLUDING SEARCH	TES STRATEGY	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR		